Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/625,061	BAKER, SCOTT L.	
Examiner	Art Unit	
Afsar M. Qureshi	2616	

SEARCHED						
Subclass	Date	Examiner				
535-595	2/26/2007	AQ				
476						
	Subclass 535-595	Subclass Date 535-595 2/26/2007				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Text, EAST, WEST, IEEE	2/17/2007	AQ			
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